

Search Notes

Application/Control No.

10/807,432

Examiner

Nam Huynh

Applicant(s)/Patent under
Reexamination

YOSHIDA ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
705	16	6/28/2006	NTH
	17		
	21		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See EAST search notes.	6/28/2006	NTH
Consulted Primary Examiners Nicholas Rosen and Ryan Zeender and obtained search 705 search area.	6/9/2006	